

FORM PTO 1449 (modified)  U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE  LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary)				ATTY DOCKET NO. <b>862.3016</b>		APPLICATION NO. <b>09/374,580 #9</b>	
<div style="border: 1px solid black; border-radius: 50%; padding: 10px; display: inline-block;">             OFFICE              MAY 07 2001              PATENT &amp; TRADEMARK OFFICE           </div>				APPLICANT <b>TATSUO FURUKAWA ET AL.</b>			
				FILING DATE <b>August 16, 1999</b>		GROUP <b>2854</b>	
U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
CA		4,313,124	1/1982	Hara	346	140R	
CA		4,345,262	8/1982	Shirato et al.	346	140R	
CA		4,459,600	7/1984	Sato et al.	346	140R	
CA		4,463,359	7/1984	Ayata et al.	346	1.1	
CA		4,558,333	12/1985	Sugitani et al.	346	140R	
CA		4,608,577	8/1986	Hori	346	140R	
CA		4,723,129	2/1988	Endo et al.	346	1.1	
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
CA		54-56847	5/1979	Japan			Abst.
CA		59-123670	7/1984	Japan			Abst.
CA		59-138461	8/1984	Japan			Abst.
CA		60-71260	4/1985	Japan			Abst.
CA		5-185594	7/1993	Japan			Abst.
CA		8-72310	3/1996	Japan			Abst.
CA		8-156,257	6/1996	Japan			Abst.
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)							
EXAMINER <b>NOLAN</b>				DATE CONSIDERED <b>8-19-01</b>			

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
CH	4,740,796	4/1988	Endo et al.	346	1.1		
CH	5,602,576	2/1997	Murooka et al.	347	59		
CH	5,731,828	3/1998	Ishinaga et al.	347	62		
CH	5,851,075	12/1998	Imai	400	120.14		
CH	5,880,762	3/1999	Ishinaga et al.	347	62		
CH	5,892,532	4/1999	Katakura et al.	347	240		
CH	6,116,714	9/2000	Imanaka et al.	347	19		
FOREIGN PATENT DOCUMENTS							
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT	
CH	8-244231	9/1996	Japan			Abst.	
CH	8-252926	10/1996	Japan			Abst.	
CH	8-034137	2/1996	Japan			Abst.	
CH	9-131879	5/1997	Japan			Abst.	
CH	0,571,093	11/1993	EPO				
CH	0,631,870	1/1995	EPO				
CH	0,661,162	7/1995	EPO				
CH	0,694,391	1/1996	EPO				
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)							
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